

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	09/913,725	YANO ET AL.	
Examiner	Art Unit	1771	Page 1 of 1
Hai Vo			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,861,211	01-1999	Thakkar et al.	156/273.3
	C	US-5,656,582	08-1997	Shiraishi et al.	508/100
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Translation of JP-11-158305, Shigeru et al, 06/15/1999, 10 pages.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.